Preferred Device

Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

PNPN devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic TO-226AA package which is readily adaptable for use in automatic insertion equipment.

Features

- Sensitive Gate Allows Triggering by Microcontrollers and Other Logic Circuits
- Blocking Voltage to 600 V
- On-State Current Rating of 0.8 Amperes RMS at 80°C
- High Surge Current Capability 10 A
- Minimum and Maximum Values of IGT, VGT and IH Specified for Ease of Design
- Immunity to dV/dt 20 V/usec Minimum at 110°C
- Glass-Passivated Surface for Reliability and Uniformity
- Pb-Free Packages are Available*



ON Semiconductor®

http://onsemi.com

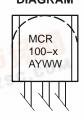
SCRs 0.8 A RMS 100 thru 600 V



MARKING DIAGRAM



TO-92 (TO-226) **CASE 029** STYLE 10



= Specific Device Code = Assembly Location

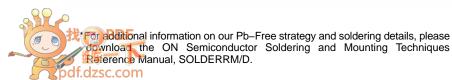
Α = Year = Work Week

PIN ASSIGNMENT					
- 1	Cathode				
2	Gate				
3	Anode				

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.



ORDERING INFORMATION

Device	Package Code	Shipping [†]			
MCR100-003		5000 Units / Bulk			
MCR100-004					
MCR100-006					
MCR100-008					
MCR100-3RL					
MCR100-6RL	TO-92 (TO-226)	2000 Units / Tape & Reel			
MCR100-6RLRA					
MCR100-6RLRM					
MCR100-6ZL1		2000 Units / Tape & Ammunition Box			
MCR100-8RL		2000 Units / Tape & Reel			
MCR100-003G					
MCR100-006G		5000 Units / Bulk			
MCR100-008G					
MCR100-3RLG					
MCR100-6RLG	TO-92 (TO-226) (Pb-Free)	2000 Units / Tubes			
MCR100-6RLRAG	(. 5 1166)	2000 Units / Tape & Reel			
MCR100-6RLRMG		000011 % /T 0.4 % B			
MCR100-6ZL1G		2000 Units / Tape & Ammunition Box			
MCR100-8RLG		2000 Units / Tape & Reel			

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T _J = -40 to 110°C, Sine Wave, 50 to 60 Hz; Gate Open) MCR100-3 MCR100-4 MCR100-6 MCR100-8	V _{DRM,} V _{RRM}	100 200 400 600	V
On-State RMS Current, (T _C = 80°C) 180° Conduction Angles	I _{T(RMS)}	0.8	А
Peak Non-Repetitive Surge Current, (1/2 Cycle, Sine Wave, 60 Hz, T _J = 25°C)	I _{TSM}	10	А
Circuit Fusing Consideration, (t = 8.3 ms)	l ² t	0.415	A ² s
Forward Peak Gate Power, (T _A = 25°C, Pulse Width ≤ 1.0 μs)	P_{GM}	0.1	W
Forward Average Gate Power, (T _A = 25°C, t = 8.3 ms)	P _{G(AV)}	0.10	W
Forward Peak Gate Current, (T _A = 25°C, Pulse Width ≤ 1.0 μs)	I _{GM}	1.0	А
Reverse Peak Gate Voltage, ($T_A = 25^{\circ}C$, Pulse Width $\leq 1.0 \mu s$)	V_{GRM}	5.0	V
Operating Junction Temperature Range @ Rate V _{RRM} and V _{DRM}	TJ	-40 to 110	°C
Storage Temperature Range	T _{stg}	-40 to 150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate

^{1.} V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case Junction-to-Ambient	R _{θJC} R _{θJA}	75 200	°C/W
Lead Solder Temperature (<1/16" from case, 10 secs max)	T∟	260	°C

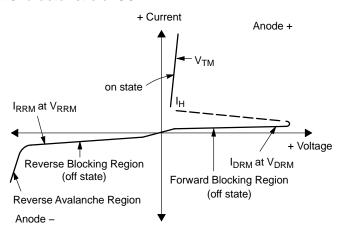
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

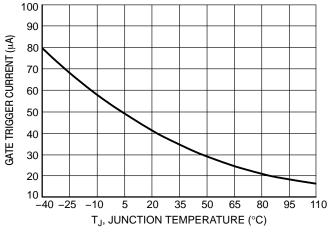
Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Peak Repetitive Forward or Reverse Blocking Current (Note 2) $T_C = 25$	I _{DRM} , I _{RRM}	_	_	10	μΑ
$(V_D = Rated V_{DRM} \text{ and } V_{RRM}; R_{GK} = 1 \text{ k}\Omega)$ $T_C = 11$	0°C	_	-	100	
ON CHARACTERISTICS	-	- ·	-	-	-
Peak Forward On–State Voltage* (I _{TM} = 1.0 A Peak @ T _A = 25°C)	V_{TM}	-	-	1.7	V
Gate Trigger Current (Continuous dc) (Note 3) $T_{C} = 25^{\circ}$ (V _{AK} = 7.0 Vdc, R _L = 100 Ω)	C I _{GT}	-	40	200	μΑ
Holding Current ⁽²⁾ $T_C = 25^{\circ}$ $(V_{AK} = 7.0 \text{ Vdc}, \text{ Initiating Current} = 20 \text{ mA})$ $T_C = -40^{\circ}$	· · ·		0.5 -	5.0 10	mA
$ \begin{array}{ll} \text{Latch Current} & & & & & & & \\ \text{($V_{AK}=7.0$ V, Ig} = 200 \; \mu\text{A}) & & & & & \\ \end{array} $	_		0.6 -	10 15	mA
Gate Trigger Voltage (Continuous dc) (Note 3) $T_C = 25^{\circ}$ (V _{AK} = 7.0 Vdc, R _L = 100 Ω) $T_C = -40^{\circ}$ C	C V _{GT}		0.62	0.8 1.2	V
DYNAMIC CHARACTERISTICS					
Critical Rate of Rise of Off–State Voltage (V_D = Rated V_{DRM} , Exponential Waveform, R_{GK} = 1000 Ω , T_J = 110	dV/dt	20	35	-	V/μs
Critical Rate of Rise of On–State Current (I _{PK} = 20 A; Pw = 10 μsec; diG/dt = 1 A/μsec, Igt = 20 mA)	di/dt	-	-	50	A/μs

^{*}Indicates Pulse Test: Pulse Width \leq 1.0 ms, Duty Cycle \leq 1%. 2. R_{GK} = 1000 Ω included in measurement. 3. Does not include R_{GK} in measurement.

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off State Forward Voltage
I _{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Off State Reverse Voltage
I _{RRM}	Peak Reverse Blocking Current
V_{TM}	Peak on State Voltage
I _H	Holding Current

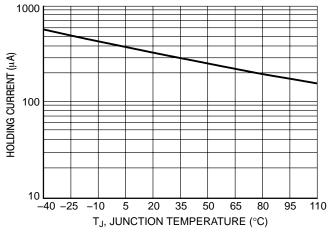




1.0 0.9 GATE TRIGGER VOLTAGE (VOLTS) 0.8 0.7 0.6 0.5 0.4 0.3 -40 –25 35 50 20 65 80 95 110 T_J, JUNCTION TEMPERATURE (°C)

Figure 1. Typical Gate Trigger Current versus **Junction Temperature**

Figure 2. Typical Gate Trigger Voltage versus **Junction Temperature**



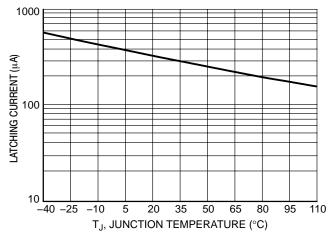
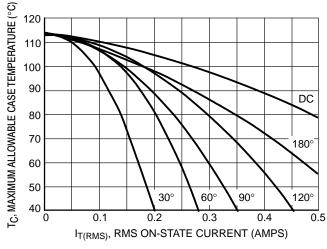


Figure 3. Typical Holding Current versus **Junction Temperature**

Figure 4. Typical Latching Current versus **Junction Temperature**



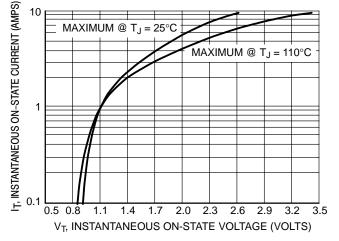


Figure 5. Typical RMS Current Derating

Figure 6. Typical On-State Characteristics

10

TO-92 EIA RADIAL TAPE IN FAN FOLD BOX OR ON REEL

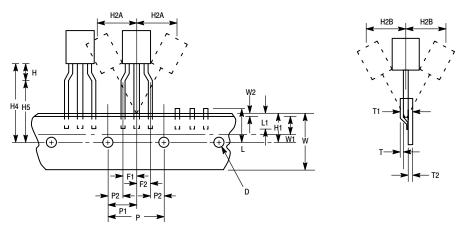


Figure 7. Device Positioning on Tape

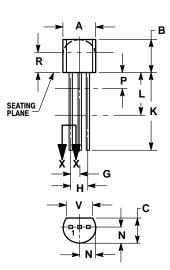
		Specification Inches Millimeter			
				Millir	neter
Symbol	Item	Min	Max	Min	Max
D	Tape Feedhole Diameter	0.1496	0.1653	3.8	4.2
D2	Component Lead Thickness Dimension	0.015	0.020	0.38	0.51
F1, F2	Component Lead Pitch	0.0945	0.110	2.4	2.8
Н	Bottom of Component to Seating Plane	.059	.156	1.5	4.0
H1	Feedhole Location	0.3346	0.3741	8.5	9.5
H2A	Deflection Left or Right	0	0.039	0	1.0
H2B	Deflection Front or Rear	0	0.051	0	1.0
H4	Feedhole to Bottom of Component	0.7086	0.768	18	19.5
H5	Feedhole to Seating Plane	0.610	0.649	15.5	16.5
L	Defective Unit Clipped Dimension	0.3346	0.433	8.5	11
L1	Lead Wire Enclosure	0.09842	_	2.5	_
Р	Feedhole Pitch	0.4921	0.5079	12.5	12.9
P1	Feedhole Center to Center Lead	0.2342	0.2658	5.95	6.75
P2	First Lead Spacing Dimension	0.1397	0.1556	3.55	3.95
T	Adhesive Tape Thickness	0.06	0.08	0.15	0.20
T1	Overall Taped Package Thickness		0.0567		1.44
T2	Carrier Strip Thickness	0.014	0.027	0.35	0.65
W	Carrier Strip Width	0.6889	0.7481	17.5	19
W1	Adhesive Tape Width	0.2165	0.2841	5.5	6.3
W2	Adhesive Tape Position	.0059	0.01968	.15	0.5

NOTES:

- 1. Maximum alignment deviation between leads not to be greater than 0.2 mm.
- 2. Defective components shall be clipped from the carrier tape such that the remaining protrusion (L) does not exceed a maximum of 11 mm.
- 3. Component lead to tape adhesion must meet the pull test requirements.
- 4. Maximum non-cumulative variation between tape feed holes shall not exceed 1 mm in 20 pitches.
- 5. Holddown tape not to extend beyond the edge(s) of carrier tape and there shall be no exposure of adhesive.
- 6. No more than 1 consecutive missing component is permitted.
- 7. A tape trailer and leader, having at least three feed holes is required before the first and after the last component.
- 8. Splices will not interfere with the sprocket feed holes.

PACKAGE DIMENSIONS

TO-92 (TO-226) CASE 029-11 ISSUE AL





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
 YAA FM 1000
 - Y14.5M, 1982.

 CONTROLLING DIMENSION: INCH.
- 3. CONTOUR OF PACKAGE BEYOND DIMENSION R IS UNCONTROLLED.
- LEAD DIMENSION IS UNCONTROLLED IN P AND BEYOND DIMENSION K MINIMUM.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.175	0.205	4.45	5.20
В	0.170	0.210	4.32	5.33
С	0.125	0.165	3.18	4.19
D	0.016	0.021	0.407	0.533
G	0.045	0.055	1.15	1.39
Н	0.095	0.105	2.42	2.66
J	0.015	0.020	0.39	0.50
K	0.500		12.70	
L	0.250		6.35	
N	0.080	0.105	2.04	2.66
P		0.100		2.54
R	0.115		2.93	
٧	0.135		3.43	

STYLE 10:

PIN 1. CATHODE

- 2. GATE
- ANODE

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